Search Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination
10/053,340	WARE ET AL.
Examiner	Art Unit
Than Nguyen	2187

Subclass	Date	Examiner
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INTERFERENCE SEARCHED		
Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
WEST Inventor PALM IEEE	3/22/2007	NTV		
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